

BQ25173-Q1 适用于 1-4 节超级电容器的汽车类、独立 800mA 线性电池充电器

1 特性

- 符合面向汽车应用的 AEC-Q100 标准
 - 温度等级 1: $-40^{\circ}\text{C} \leq T_A \leq 125^{\circ}\text{C}$
 - HBM ESD 分类等级 2
 - CDM ESD 分类等级 C4B
- 可承受 40V 负载突降, 支持直接从 3V 至 18V 工作范围的主电池为备用超级电容器充电
- 自动睡眠模式, 可降低功耗
 - 350nA 输出漏电流
 - 禁用充电时, 输入漏电流为 2μA
- 支持从 0V 为 1 至 4 节超级电容器充电
- 操作可使用外部电阻器进行编程
 - FB 引脚用于调节超级电容器稳压电压
 - ISET 用于设置 10mA 至 800mA 的充电电流
- 高精度
 - 充电电压精度为 $\pm 1\%$
 - 充电电流精度为 $\pm 10\%$
- 充电特性
 - CE 引脚用于充电功能控制
 - 用于状态和故障指示的开漏输出
 - 用于电源正常指示的开漏输出
- 集成故障保护
 - 18V 输入过压保护
 - 1000mA 过流保护
 - 125°C 热调节; 150°C 热关断保护
 - ISET 引脚短路保护

2 应用

- 远程信息处理控制单元 (TCU)
- 紧急呼叫 (eCall)
- 车队管理、资产跟踪

3 说明

BQ25173-Q1 是一款符合汽车标准的 800mA 线性充电器, 适用于面向空间受限型应用的 1-4 节超级电容器。该器件具有为超级电容器充电的单电源输出。可以将系统负载与超级电容器并联, 并且充电电流由系统和超级电容器共享。

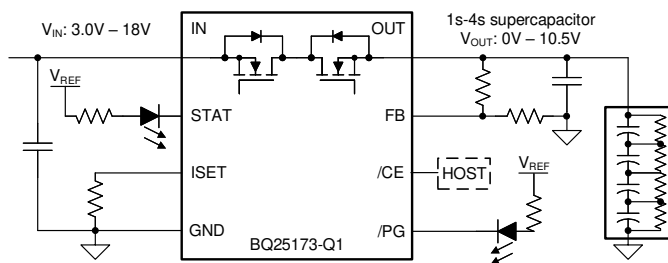
在充电期间, 内部控制环路会监视 IC 结温并在超过内部温度阈值 T_{REG} 时减小充电电流。此功能可为完全放电的超级电容器提供快速充电。

充电器功率级和充电电流检测功能均完全集成。该充电器具有高精度电流和电压调节环路功能、充电状态显示和充电功能控制。充电电压和快速充电电流可通过外部电阻编程设定。

器件信息

器件型号	封装 ⁽¹⁾	封装尺寸 (标称值)
BQ25173-Q1	VSON (10)	3.0mm x 3.0mm

(1) 如需了解所有可用封装, 请参阅数据表末尾的可订购产品附录。



简化原理图



Table of Contents

1 特性	1	8 Application and Implementation	16
2 应用	1	8.1 Application Information.....	16
3 说明	1	8.2 Typical Applications.....	16
4 Revision History	2	9 Power Supply Recommendations	20
5 Pin Configuration and Functions	3	10 Layout	20
6 Specifications	4	10.1 Layout Guidelines.....	20
6.1 Absolute Maximum Ratings	4	10.2 Layout Example.....	20
6.2 ESD Ratings	4	10.3 Thermal Considerations.....	20
6.3 Recommended Operating Conditions	4	11 Device and Documentation Support	22
6.4 Thermal Information	5	11.1 Device Support.....	22
6.5 Electrical Characteristics	6	11.2 接收文档更新通知.....	22
6.6 Timing Requirements	7	11.3 支持资源.....	22
6.7 Typical Characteristics.....	8	11.4 Trademarks.....	22
7 Detailed Description	10	11.5 静电放电警告.....	22
7.1 Overview.....	10	11.6 术语表.....	22
7.2 Functional Block Diagram.....	11	12 Mechanical, Packaging, and Orderable Information	23
7.3 Feature Description.....	12		
7.4 Device Functional Modes.....	14		

4 Revision History

DATE	REVISION	NOTES
July 2023	*	Initial Release

5 Pin Configuration and Functions

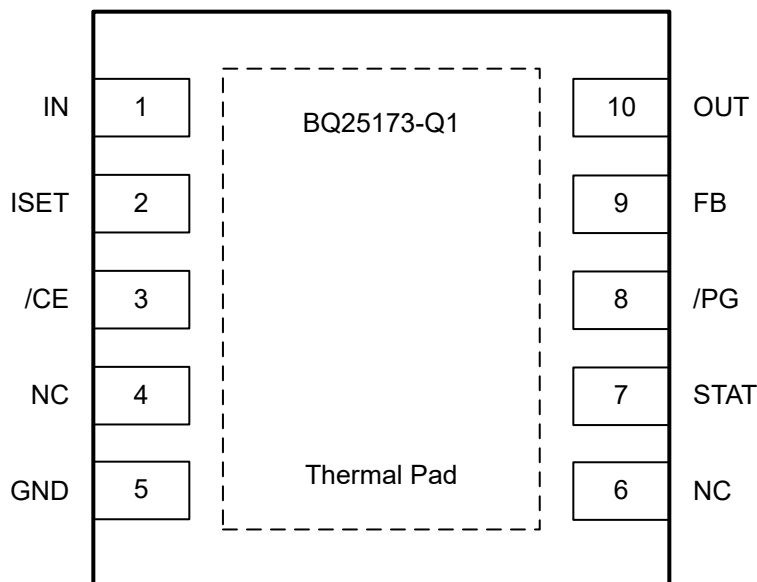


图 5-1. DRC VSON Package 10-Pin (Top View)

表 5-1. Pin Functions

PIN		I/O ⁽¹⁾	DESCRIPTION
NAME	NO.		
IN	1	P	Input power. Connect to external DC supply. Bypass IN with at least 1- μ F capacitor to GND, placed close to the IC.
ISET	2	I	Programs the device fast-charge current, I_{CHG} . External resistor from ISET to GND defines fast-charge current value. Expected range is 30 k Ω (10 mA) to 375 Ω (800 mA). $I_{CHG} = K_{ISET} / R_{ISET}$.
CE	3	I	Active low charge enable pin. Charging is enabled when $\overline{CE}$ pin is low. IC remains in Shutdown mode and charging is disabled when $\overline{CE}$ pin is high. An internal pulldown resistor (R_{PD_CE}) enables the IC by default if this pin is floating.
NC	4	-	No connect pin, leave floating
GND	5	-	Ground pin
NC	6	-	No connect pin, leave floating
STAT	7	O	Open-drain charger status indication output. Connect to pullup rail with a 10-k Ω resistor. LOW indicates V_{OUT} has reached 98% of the programmable regulation voltage, V_{REG} . HIGH indicates charge in progress.
PG	8	O	Open-drain charger power-good output. Connect to pullup rail with a 10-k Ω resistor. $\overline{PG}$ goes LOW when $V_{IN} > V_{IN_LOWV}$ and $V_{OUT} + V_{SLEEPZ} < V_{IN} < V_{IN_OV}$.
FB	9	I	Programs the supercapacitor regulation voltage, V_{REG} . Use a feedback divider not exceeding 1 M Ω from V_{OUT} to GND to set the regulation voltage. The bottom of the resistor divider network can be connected to PG for reduced power consumption when the input is removed (for $V_{REG} \leq 5$ V).
OUT	10	P	Supercapacitor connection. System load may be connected in parallel with supercapacitor. Bypass OUT with at least 1- μ F capacitor to GND, placed close to the IC.
Thermal Pad	—	P	Exposed pad beneath the IC for heat dissipation. Solder thermal pad to the board with vias connecting to solid GND plane.

(1) I = Input, O = Output, P = Power

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
Voltage	IN	- 0.3	40	V
Voltage	OUT	- 0.3	13	V
Voltage	$\overline{CE}$, FB, ISET, STAT, $\overline{PG}$	- 0.3	5.5	V
Output Sink Current	$\overline{PG}$, STAT		5	mA
Junction temperature, T_J		- 40	150	°C
Storage temperature, T_{stg}		- 65	150	°C

- (1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. Absolute maximum ratings do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If briefly operating outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not sustain damage, but it may not be fully functional. Operating the d ality, performance, and shorten the device lifetime.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per AEC Q100-002 ⁽¹⁾ HBM ESD classification level 2	±2500	V
		Charged device model (CDM), per AEC Q100-011 CDM ESD classification level C4B	±1500	

- (1) AEC Q100-002 indicates that HBM stressing must be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V_{IN}	Input voltage	3.0		18	V
V_{OUT}	Output voltage	0		10.5	V
I_{OUT}	Output current			0.8	A
T_J	Junction temperature	- 40		125	°C
C_{IN}	IN capacitor	1			μF
C_{OUT}	OUT capacitor	1			μF
R_{ISET}	ISET resistor	0.375		30	k Ω

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		BQ25173-Q1	UNIT
		DRC	
		10 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance (JEDEC ⁽¹⁾)	60.3	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	73.1	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	34.2	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	6.0	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	34.2	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	16.7	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.5 Electrical Characteristics

3.0V < V_{IN} < 18V and V_{IN} > V_{OUT} + V_{SLEEP}, T_J = -40°C to +125°C, and T_J = 25°C for typical values (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
QUIESCENT CURRENTS						
I _{Q_OUT}	Quiescent output current (OUT)	OUT= 4.2V, IN floating or IN = 0V - 5V, Charge Disabled (CE high), T _J = 25 °C		0.350	0.6	μA
		OUT= 4.2V, IN floating or IN = 0V - 5V, Charge Disabled (CE high), T _J < 105 °C		0.350	0.8	μA
I _{Q_OUT}	Quiescent output current (OUT)	OUT = 8.4V, IN floating or IN = 0V - 14V, Charge Disabled (CE high), T _J = 25 °C		0.8	1.2	μA
		OUT = 8.4V, IN floating or IN = 0V - 14V, Charge Disabled (CE high), T _J < 105 °C		0.8	1.5	μA
I _{SD_IN}	Shutdown input current (IN) with charge disabled	IN = 5V, Charge Disabled (CE high), no capacitor		2	4	μA
		IN = 14V, Charge Disabled (CE high), no capacitor		3.5	6	μA
I _{Q_IN}	Quiescent input current (IN)	IN = 5V, OUT = 3.8V, Charge Enabled (CE low), ICHG = 0A		0.45	0.6	mA
I _{Q_IN}	Quiescent input current (IN)	IN = 14V, OUT = 7.6V, Charge Enabled (CE low), ICHG = 0A		0.45	0.6	mA
INPUT						
V _{IN_OP}	IN operating range		3.0		18	V
V _{IN_LOWV}	IN voltage to start charging	IN rising	3.05	3.09	3.15	V
V _{IN_LOWV}	IN voltage to stop charging	IN falling	2.80	2.95	3.10	V
V _{SLEEPZ}	Exit sleep mode threshold	IN rising, V _{IN} - V _{OUT} , OUT = 4V	95	135	175	mV
V _{SLEEP}	Enter sleep mode threshold	IN falling, V _{IN} - V _{OUT} , OUT = 4V		80		mV
V _{IN_OV}	VIN overvoltage rising threshold	IN rising	18.1	18.4	18.7	V
V _{IN_OVZ}	VIN overvoltage falling threshold	IN falling		18.2		V
CONFIGURATION PINS SHORT/OPEN PROTECTION						
R _{ISET_SHORT}	Highest resistor value considered short	R _{ISET} below this at startup, charger does not initiate charge, power cycle or CE toggle to reset			350	Ω
CHARGER						
V _{FB_REF}	Feedback reference voltage			0.8		V
V _{FB_REF_ACC}	Feedback reference voltage accuracy	T _j = -40°C to 125°C	-1		1	%
I _{CHG_RANGE}	Typical charge current regulation range	V _{OUT} > V _{BAT_LOWV}	10		800	mA
K _{ISET}	Charge current setting factor, I _{CHG} = K _{ISET} / R _{ISET}	10mA < ICHG < 800mA	270	300	330	A Ω
I _{CHG_ACC}	Charge current accuracy	R _{ISET} = 375 Ω , OUT = 3.8V or 7.6V	720	800	880	mA
		R _{ISET} = 600 Ω , OUT = 3.8V or 7.6V	450	500	550	mA
		R _{ISET} = 3.0k Ω , OUT = 3.8V or 7.6V	90	100	110	mA
		R _{ISET} = 30k Ω , OUT = 3.8V or 7.6V	9	10	11	mA
V _{CHG}	Supercapacitor charged threshold	OUT rising, as percentage of FB regulation target		98		%
R _{ON}	Charging path FET on-resistance	IOUT = 400mA, T _J = 25°C		845	1000	m Ω
		IOUT = 400mA, T _J = -40 - 125°C		845	1450	m Ω
CHARGER PROTECTION						
I _{OUT_OCP}	Output current limit threshold	IOUT rising	0.9	1	1.1	A

6.5 Electrical Characteristics (continued)

$3.0V < V_{IN} < 18V$ and $V_{IN} > V_{OUT} + V_{SLEEP}$, $T_J = -40^{\circ}C$ to $+125^{\circ}C$, and $T_J = 25^{\circ}C$ for typical values (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
TEMPERATURE REGULATION AND TEMPERATURE SHUTDOWN						
T_{REG}	Typical junction temperature regulation			125		$^{\circ}C$
T_{SHUT}	Thermal shutdown rising threshold	Temperature increasing		150		$^{\circ}C$
	Thermal shutdown falling threshold	Temperature decreasing		135		$^{\circ}C$
LOGIC INPUT PIN (/CE)						
V_{IH}	Input high threshold level		1.3			V
V_{IL}	Input low threshold level				0.4	V
R_{PD_CE}	$\overline{CE}$ pin internal pulldown resistor		3.3			M Ω
LOGIC OUTPUT PIN (STAT, PG)						
V_{OL}	Output low threshold level	Sink current = 5mA			0.4	V
I_{OUT_BIAS}	High-level leakage current	Pull up rail 3.3V			1	μA

6.6 Timing Requirements

		MIN	NOM	MAX	UNIT
CHARGER					
$t_{OUT_OCP_DGL}$	Deglitch time for I_{OUT_OCP} , I_{OUT} rising		100		μs

6.7 Typical Characteristics

$C_{IN} = 1 \mu F$, $C_{OUT} = 1 \mu F$

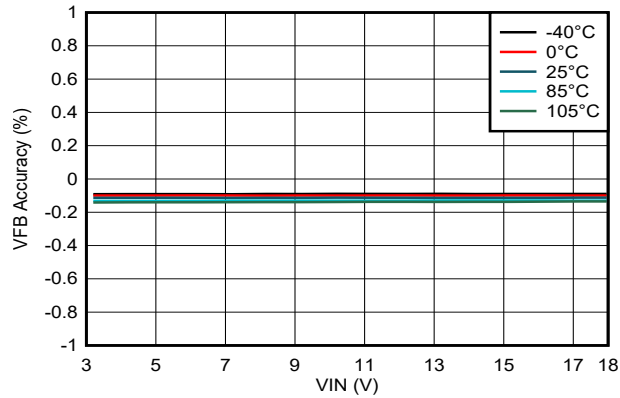


图 6-1. Line Regulation (V_{FB})

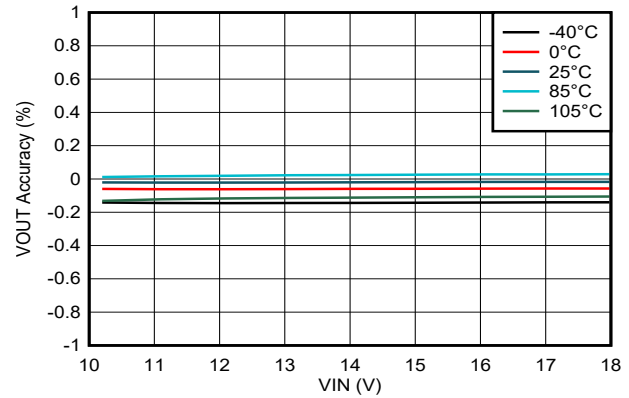


图 6-2. Line Regulation (V_{OUT})

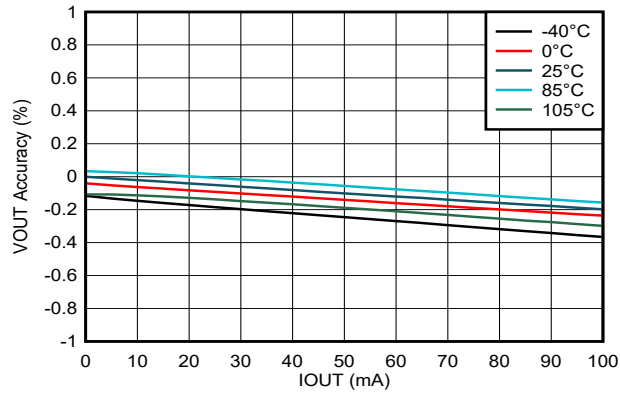


图 6-3. Load Regulation

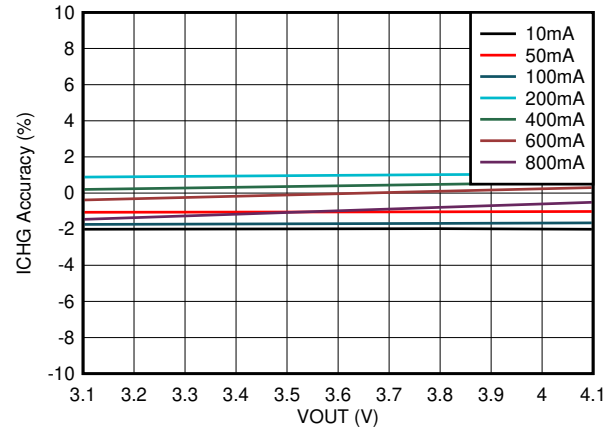


图 6-4. ICHG Accuracy vs. V_{OUT}

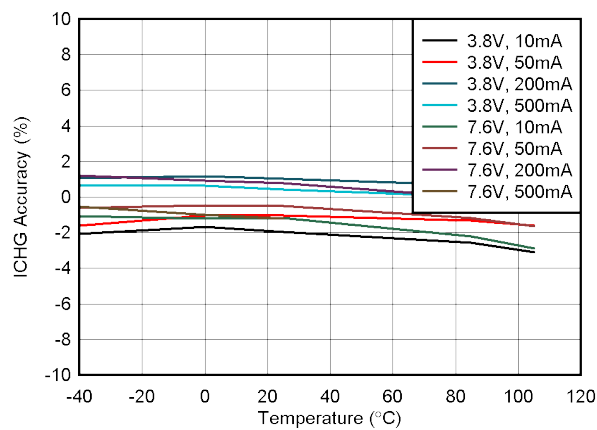


图 6-5. ICHG Accuracy vs. Temperature

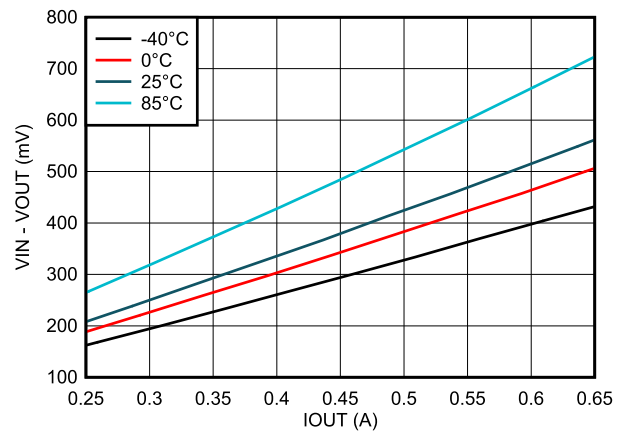


图 6-6. Dropout Voltage vs. Output Current

6.7 Typical Characteristics (continued)

$C_{IN} = 1 \mu F$, $C_{OUT} = 1 \mu F$

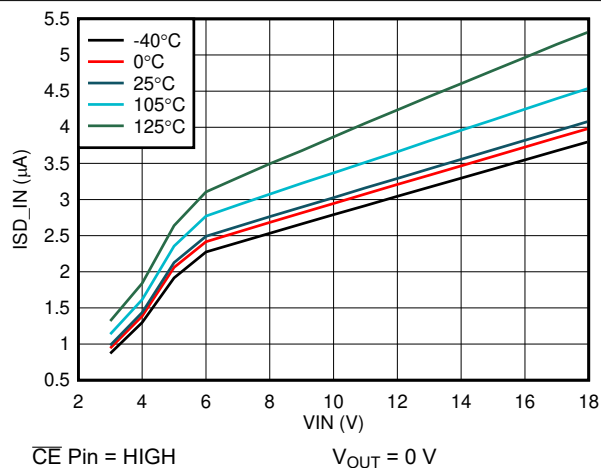


图 6-7. Input Shutdown Current vs. Input Voltage

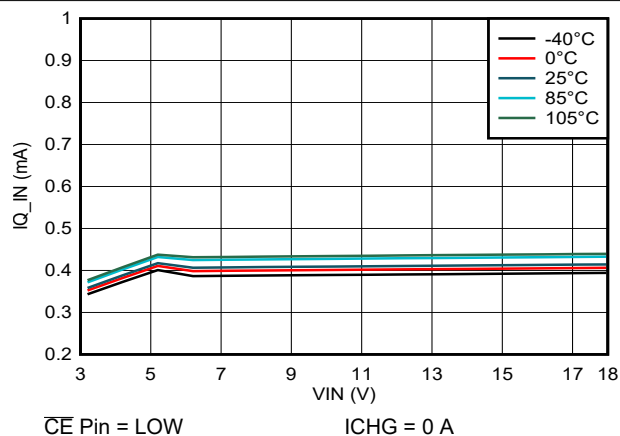


图 6-8. Input Quiescent Current vs. Input Voltage

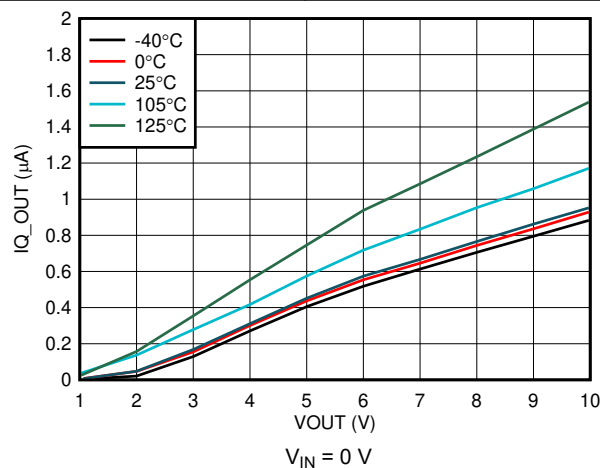


图 6-9. Output Quiescent Current vs. Output Voltage

7 Detailed Description

7.1 Overview

The BQ25173-Q1 is an automotive rated, 800-mA linear charger for 1- to 4-cell supercapacitors targeted at space-limited applications. The device has a single power output that charges the supercapacitor. The system load can be placed in parallel with the supercapacitor and the charge current is shared between the system and supercapacitor.

The charger is designed for a single path from the input to the output to charge the supercapacitor. Upon application of a valid input power source, the ISET pin is checked for short circuit.

The device attempts to charge the supercapacitor at the fast-charge current setting from fully discharged (0 V) up to the programmable regulation voltage, V_{REG} . Power dissipation in the IC is greatest in fast charge with a lower supercapacitor voltage. If the IC temperature reaches T_{REG} , the IC enters thermal regulation and reduces the charge current as needed to keep the temperature from rising any further. The fast-charge current is programmed using the ISET pin. 图 7-1 shows the typical supercapacitor charging profile with thermal regulation. At lower fast-charge settings, the junction temperature of the IC is less than T_{REG} and thermal regulation is not entered.

Once the supercapacitor has charged to the regulation voltage, the voltage loop takes control and holds the voltage at the regulation voltage as the current tapers down to zero. There is no current termination threshold as seen in Li-ion chargers.

Further details are described in 节 7.3.

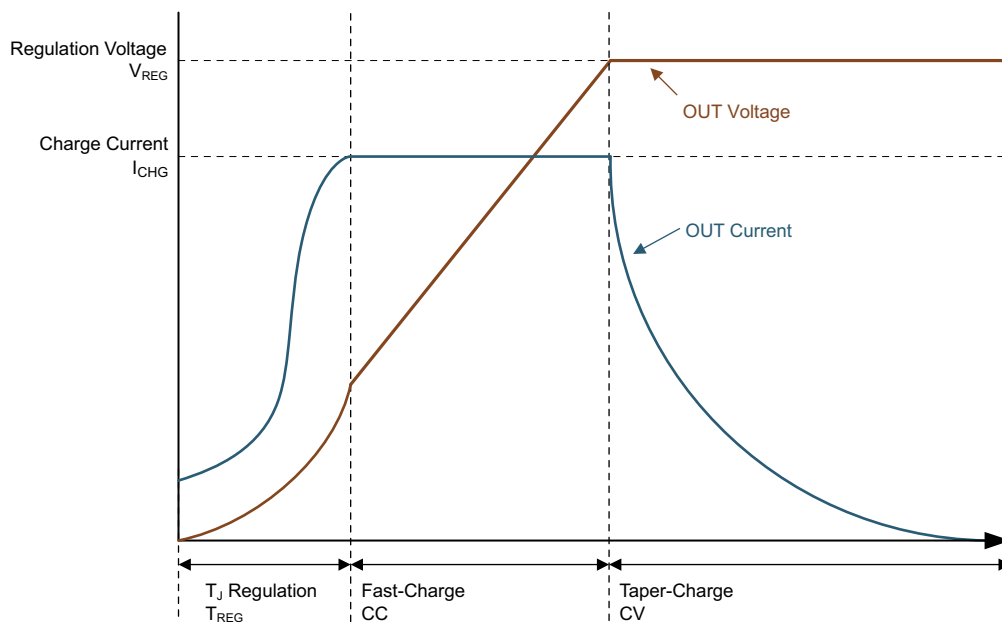
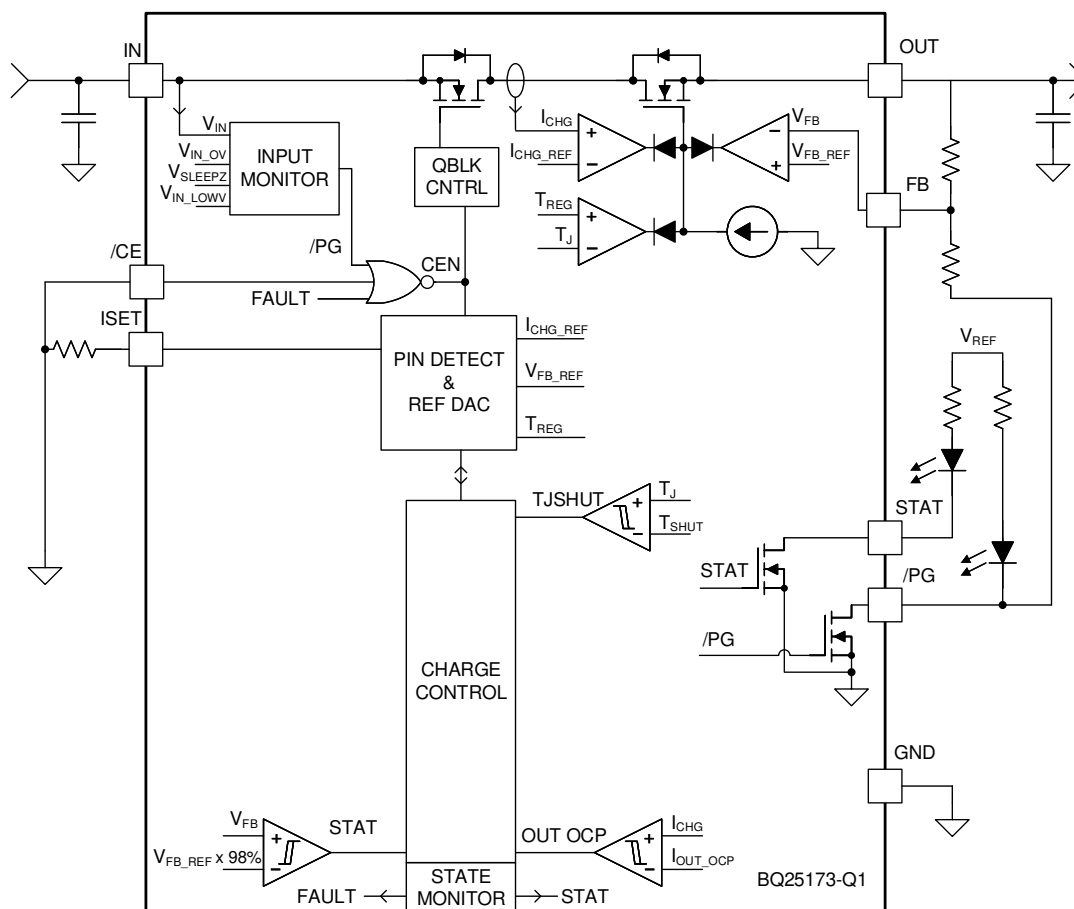


图 7-1. Supercapacitor Charging Profile with Thermal Regulation

7.2 Functional Block Diagram



7.3 Feature Description

7.3.1 Device Power Up from Input Source

When an input source is plugged in and charge is enabled, the device checks the input source voltage to turn on all of the bias circuits. The device detects and sets the charge current limits before the linear regulator is started. The power-up sequence from the input source is listed below:

1. ISET pin detection
2. Charger power up

7.3.1.1 ISET Pin Detection

After a valid VIN is plugged in and the $\overline{CE}$ pin is pulled LOW, the device checks the resistor on the ISET pin for a short circuit ($R_{ISET} < R_{ISET_SHORT}$). If a short condition is detected, the charger remains in the FAULT state until the input or $\overline{CE}$ pin is toggled. If the ISET pin is open circuit, the charger proceeds through pin detection and starts the charger with no charge current. This pin is monitored during charging and changes in R_{ISET} while the charger is operating immediately translates to changes in charge current.

An external pulldown resistor ($\pm 1\%$ or better recommended to minimize charge current error) from the ISET pin to GND sets the charge current as:

$$I_{CHG} = \frac{K_{ISET}}{R_{ISET}} \quad (1)$$

where:

- I_{CHG} is the desired fast-charge current
- K_{ISET} is the gain factor found in the electrical specifications
- R_{ISET} is the pulldown resistor from the ISET pin to GND

For charge currents below 50 mA, an extra RC circuit is recommended on the ISET pin to achieve a more stable current signal. For greater accuracy at lower currents, part of the current-sensing FET is disabled to give better resolution.

7.3.2 Supercapacitor Regulation Voltage

The device allows for the supercapacitor regulation voltage, V_{REG} , to be programmed with a resistor divider between the OUT and FB pins:

$$V_{REG} = V_{FB_REF} \times \frac{R_{FBT} + R_{FBB}}{R_{FBB}} \quad (2)$$

Where V_{FB_REF} is listed in the electrical characteristics table. The resistors can be seen in [图 7-2](#). The total resistance ($R_{FBT} + R_{FBB}$) should not exceed 1 M Ω .

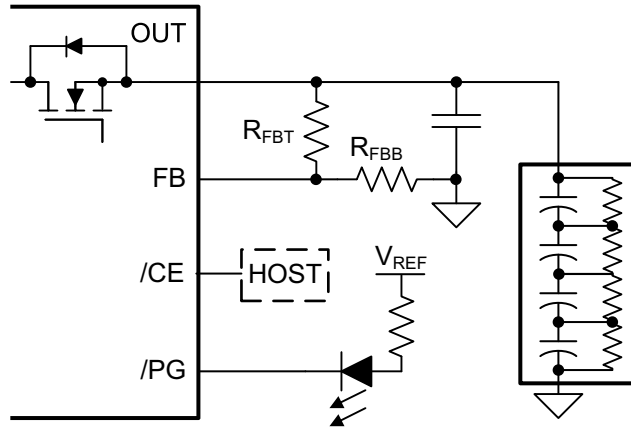


图 7-2. BQ25173-Q1 Feedback Divider

7.3.3 Supercapacitor Charging Profile

The device charges a supercapacitor in two phases: constant current and constant voltage. Power dissipation in the IC is greatest in fast charge with a lower supercapacitor voltage. If the IC temperature reaches T_{REG} , the IC enters thermal regulation and reduces the charge current as needed to keep the temperature from rising any further. As the supercapacitor approaches the regulation voltage, the current tapers down to 0 mA. There is no current termination threshold as seen in Li-Ion chargers.

7.3.4 Status Outputs ($\overline{PG}$, STAT)

7.3.4.1 Power Good Indicator ($\overline{PG}$ Pin)

This open-drain pin pulls LOW to indicate a good input source when:

1. V_{IN} above V_{IN_LOWV}
2. V_{IN} above $V_{OUT} + V_{SLEEPZ}$ (not in SLEEP)
3. V_{IN} below V_{IN_OV}

The $\overline{PG}$ pin can be used as the GND connection for the bottom resistor in the feedback divider to prevent divider leakage current from the supercapacitor when the charger is disabled. This is only recommended when $V_{REG} \leq 5$ V (1-2s supercapacitors) as the absolute maximum rating on $\overline{PG}$ is 5.5 V. An example circuit can be seen in 图 8-1.

7.3.4.2 Charging Status Indicator (STAT)

The device indicates the charging state on the open-drain STAT pin. This pin can drive an LED.

表 7-1. STAT Pin State

CHARGING STATE	STAT PIN STATE
$V_{FB} < 98\%$ of V_{FB_REF} or charge disabled	High
$V_{FB} > 98\%$ of V_{FB_REF}	Low
Fault (V_{IN} OVP, OUT OCP, or ISET pin short)	Blink at 1 Hz

7.3.5 Protection Features

The device closely monitors input and output voltage, as well as internal FET current and temperature for safe linear regulator operation.

7.3.5.1 Input Overvoltage Protection (V_{IN} OVP)

If the voltage at the IN pin exceeds V_{IN_OV} , the device enters STANDBY mode. Once the IN voltage recovers to normal level, charging resumes.

7.3.5.2 Output Overcurrent Protection (OUT OCP)

During normal operation, the OUT current should be regulated to the ISET programmed value. However, if a short circuit occurs on the ISET pin, the OUT current may rise to an unintended level. If current at the OUT pin exceeds I_{OUT_OCP} , the device turns off after a deglitch, $t_{OUT_OCP_DGL}$, and the device remains latched off. An input supply or $\overline{CE}$ pin toggle is required to restart operation.

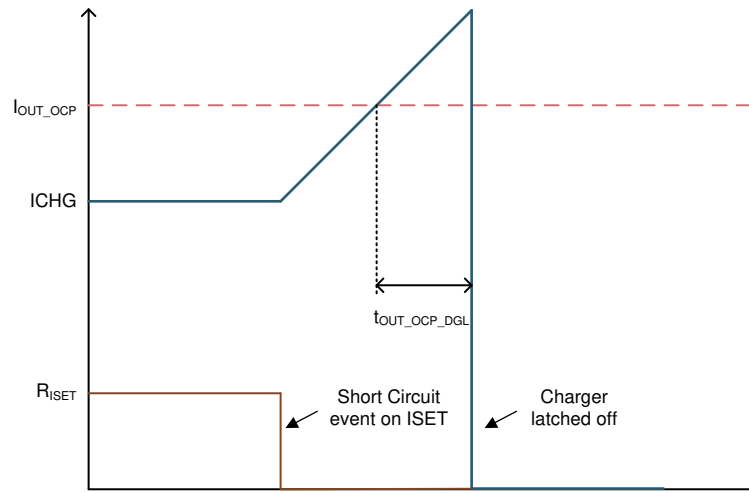


图 7-3. Overcurrent Protection

7.3.5.3 Thermal Regulation and Thermal Shutdown (T_{REG} and T_{SHUT})

The device monitors its internal junction temperature (T_J) to avoid overheating and to limit the IC surface temperature. When the internal junction temperature exceeds the thermal regulation limit, the device automatically reduces the charge current to maintain the junction temperature at the thermal regulation limit (T_{REG}). During thermal regulation, the actual charging current is usually below the programmed value on the ISET pin.

Additionally, device thermal shutdown turns off the linear regulator when the IC junction temperature exceeds the T_{SHUT} threshold. The charger resumes operation when the IC die temperature decreases below the T_{SHUT} falling threshold.

7.4 Device Functional Modes

7.4.1 Shutdown or Undervoltage Lockout (UVLO)

The device is in the shutdown state if the IN pin voltage is less than V_{IN_LOWV} . The internal circuitry is powered down, all the pins are high impedance, and the device draws from the input supply. Once the IN voltage rises above the V_{IN_LOW} threshold, the IC will enter Sleep Mode or Active Mode depending on the OUT pin voltage.

7.4.2 Sleep Mode

The device is in Sleep Mode when $V_{IN_LOWV} < V_{IN} < V_{OUT} + V_{SLEEPZ}$. The device waits for the input voltage to rise above $V_{OUT} + V_{SLEEPZ}$ to start operation.

7.4.3 Active Mode

The device is powered up and charges the supercapacitor when the $\overline{CE}$ pin is LOW and the IN voltage ramps above both V_{IN_LOWV} , and $V_{OUT} + V_{SLEEPZ}$. The device draws I_{Q_IN} from the supply to bias the internal circuitry. For details on the device power-up sequence, refer to 节 7.3.1.

7.4.3.1 Standby Mode

The device is in Standby Mode if a valid input supply is present and a recoverable fault is detected. The internal circuitry is partially biased, and the device continues to monitor for the recoverable fault to be removed.

7.4.4 Fault Mode

The fault conditions are categorized into recoverable and nonrecoverable as follows:

- Recoverable, from which the device should automatically recover once the fault condition is removed:
 - VIN OVP
- Nonrecoverable, requiring pin or input supply toggle to resume operation:
 - OUT OCP
 - ISET pin short detected

8 Application and Implementation

备注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

A typical application consists of the device configured as a standalone charger for a 1- to 4-cell supercapacitor. The regulation voltage, V_{REG} , is configured using a resistor divider between the OUT and FB pins. The charge current is configured using a pulldown resistor on the ISET pin. Pulling the $\overline{CE}$ pin above V_{IH} disables the charging function. Charger and input supply status are reported with the STAT and PG pins.

8.2 Typical Applications

8.2.1 1s Supercapacitor Charger Design Example

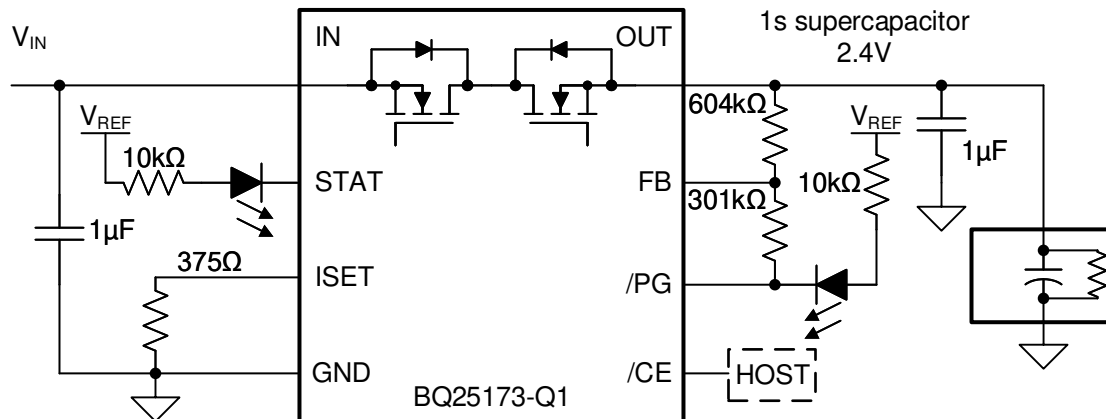


图 8-1. BQ25173-Q1 1s Supercapacitor Application Diagram

8.2.1.1 Design Requirements

- Supply voltage is 5 V to 18 V
- Fast charge current: $I_{CHG} = 800 \text{ mA}$
- Regulation voltage: $V_{REG} = 2.4 \text{ V}$
- $\overline{CE}$ is an open-drain control pin
- PG pin is used as the GND connection in the feedback divider to minimize supercapacitor current leakage

8.2.1.2 Detailed Design Procedure

- With $R_{FBT} = 604 \text{ k}\Omega$, calculate R_{FBB} so $V_{REG} = 2.4 \text{ V}$ using [方程式 2](#)
- $R_{ISET} = [K_{ISET} / I_{CHG}]$ from electrical characteristics table.
 - $K_{ISET} = 300 \text{ A}\Omega$
 - $R_{ISET} = [300 \text{ A}\Omega / 0.8 \text{ A}] = 375 \Omega$

8.2.1.3 Application Curves

$C_{IN} = 1 \mu F$, $C_{OUT} = 1 \mu F$, $C_{SC} = 25 F$, $V_{IN} = 5 V$ (unless otherwise specified)

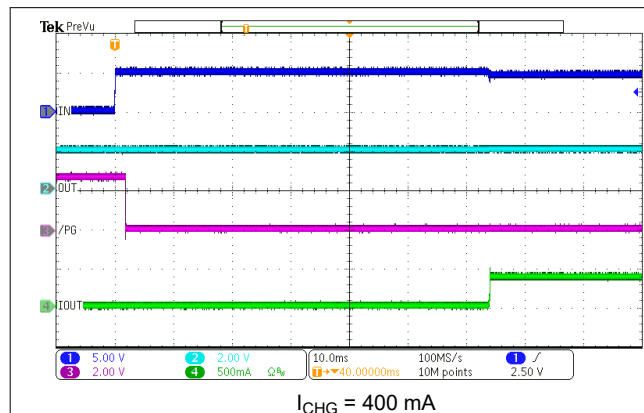


图 8-2. Power Up with Supercapacitor

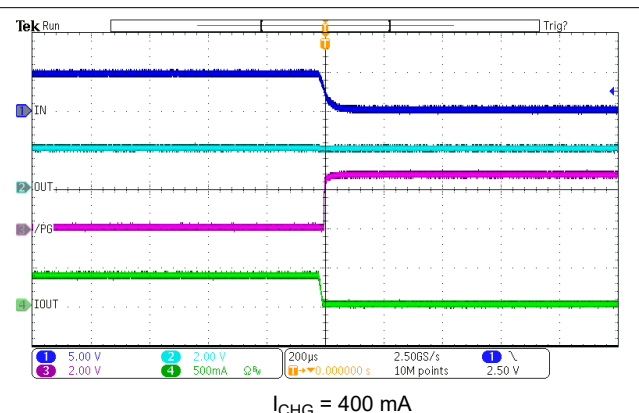


图 8-3. Power Down with Supercapacitor

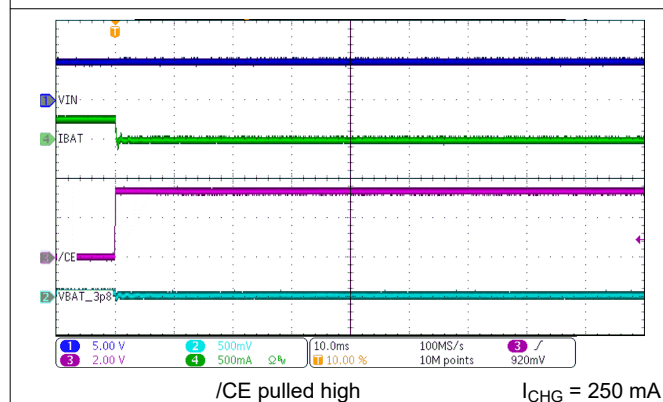


图 8-4. Charge Disable

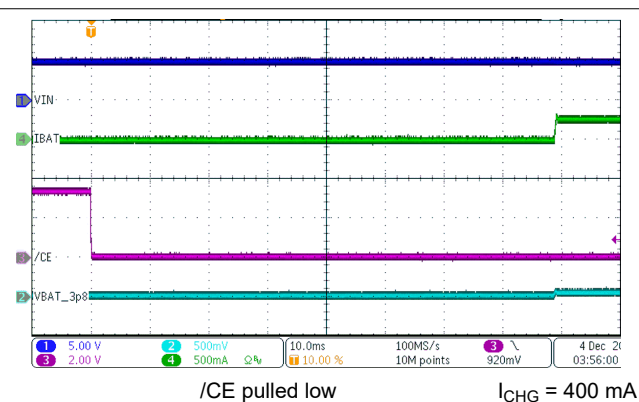


图 8-5. Charge Enable

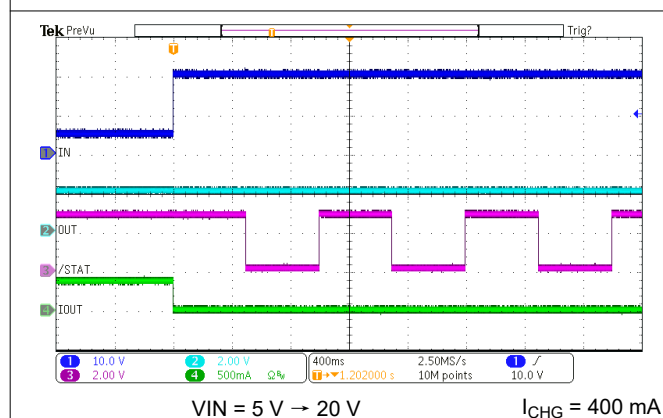


图 8-6. IN OVP Response

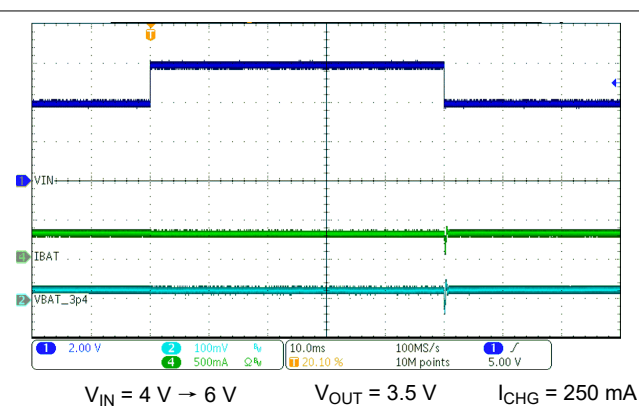


图 8-7. IN Transient Response

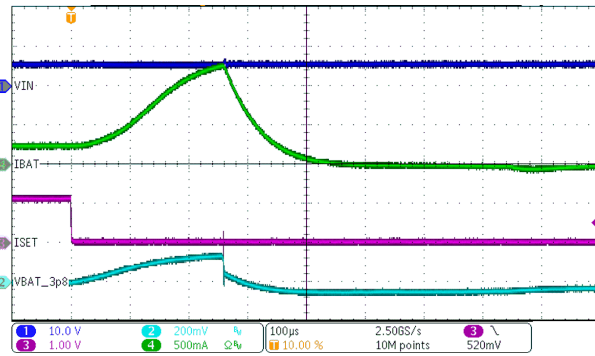


图 8-8. ISET Short-Circuit Response

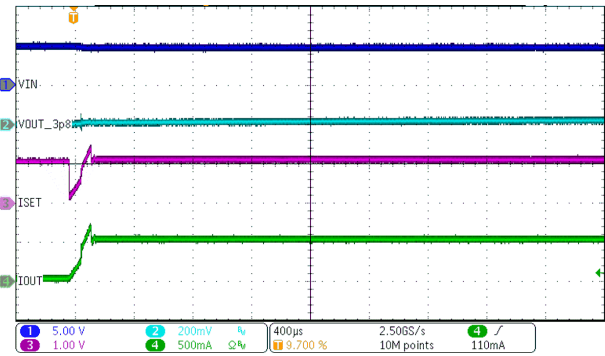


图 8-9. ISET Change Response

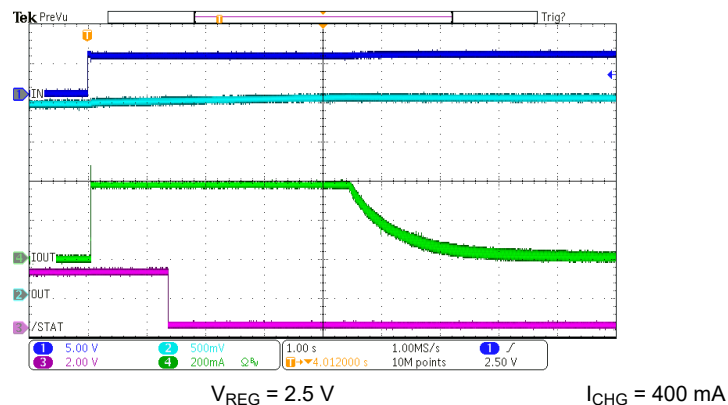


图 8-10. Charge Complete

8.2.2 4s Supercapacitor Charger Design Example

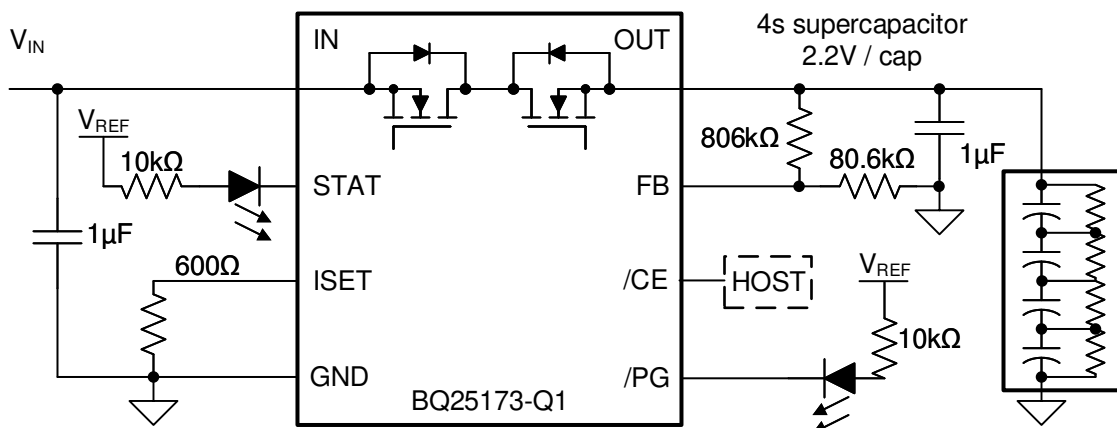


图 8-11. BQ25173-Q1 4s Supercapacitor Application Diagram

8.2.2.1 Design Requirements

The design requirements include the following:

- Supply voltage is 9 V to 18 V
- Fast charge current: $I_{CHG} = 500 \text{ mA}$
- Regulation voltage: $V_{REG} = 8.8 \text{ V}$
- $\overline{CE}$ is a control pin, pull high to disable the charger

8.2.2.2 Application Curves

For application curves, refer to [节 8.2.1.3](#).

9 Power Supply Recommendations

The device is designed to operate from an input voltage supply range between 3.0 V and 18 V (up to 40 V tolerant) and current capability of at least the maximum designed charge current. If located more than a few inches from the IN and GND pins, a larger capacitor is recommended.

10 Layout

10.1 Layout Guidelines

To obtain optimal performance, the decoupling capacitor from IN to GND and the output filter capacitor from OUT to GND should be placed as close as possible to the device, with short trace runs to both IN, OUT, and GND.

- All low-current GND connections should be kept separate from the high-current charge or discharge paths from the supercapacitor. Use a single-point ground technique incorporating both the small signal ground path and the power ground path.
- The high-current charge paths into the IN pin and from the OUT pin must be sized appropriately for the maximum charge current in order to avoid voltage drops in these traces.

10.2 Layout Example

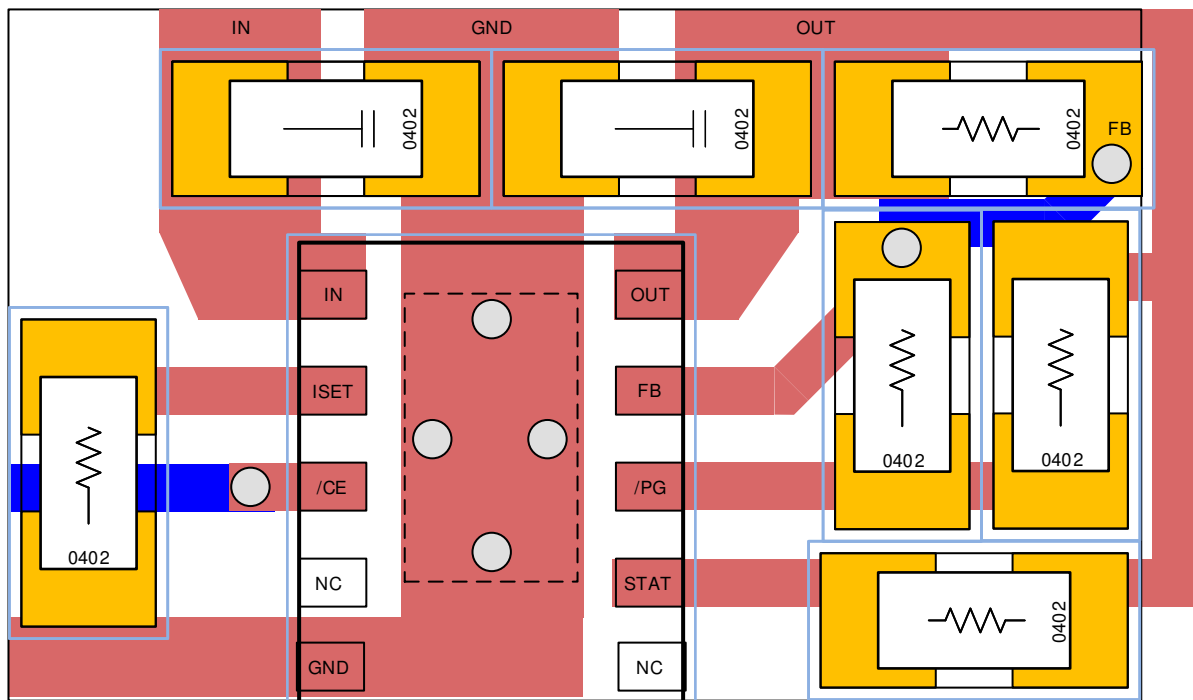


图 10-1. BQ25173-Q1 Board Layout Example

10.3 Thermal Considerations

The most common measure of package thermal performance is thermal impedance (θ_{JA}) measured (or modeled) from the chip junction to the air surrounding the package surface (ambient). The mathematical expression for θ_{JA} is:

$$\theta_{JA} = (T_J - T) / P \quad (3)$$

Where:

T_J = chip junction temperature

T = ambient temperature

P = device power dissipation

Factors that can influence the measurement and calculation of θ_{JA} include:

- Whether or not the device is board mounted
- Trace size, composition, thickness, and geometry
- Orientation of the device (horizontal or vertical)
- Volume of the ambient air surrounding the device under test and airflow
- Whether other surfaces are in close proximity to the device being tested

Due to the charge profile of supercapacitors, maximum power dissipation is typically seen at the beginning of the charge cycle when the voltage is at its lowest.

Device power dissipation, P , is a function of the charge rate and the voltage drop across the internal PowerFET. P can be calculated from the following equation during charging:

$$P = [V_{(IN)} - V_{(OUT)}] \times I_{(OUT)} \quad (4)$$

The thermal loop feature reduces the charge current to limit excessive IC junction temperature. It is recommended that the design not run in thermal regulation for typical operating conditions (nominal input voltage and nominal ambient temperatures) and use the feature for nontypical situations such as hot environments or higher than normal input source voltage. With that said, the IC will still perform as described, if the thermal loop is always active.

11 Device and Documentation Support

11.1 Device Support

11.1.1 第三方产品免责声明

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11.3 支持资源

TI E2E™ [支持论坛](#) 是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

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ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

11.6 术语表

[TI 术语表](#) 本术语表列出并解释了术语、首字母缩略词和定义。

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
BQ25173QWDRCRQ1	Active	Production	VSON (DRC) 10	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	B173Q
BQ25173QWDRCRQ1.A	Active	Production	VSON (DRC) 10	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	B173Q

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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OTHER QUALIFIED VERSIONS OF BQ25173-Q1 :

- Catalog : [BQ25173](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product

GENERIC PACKAGE VIEW

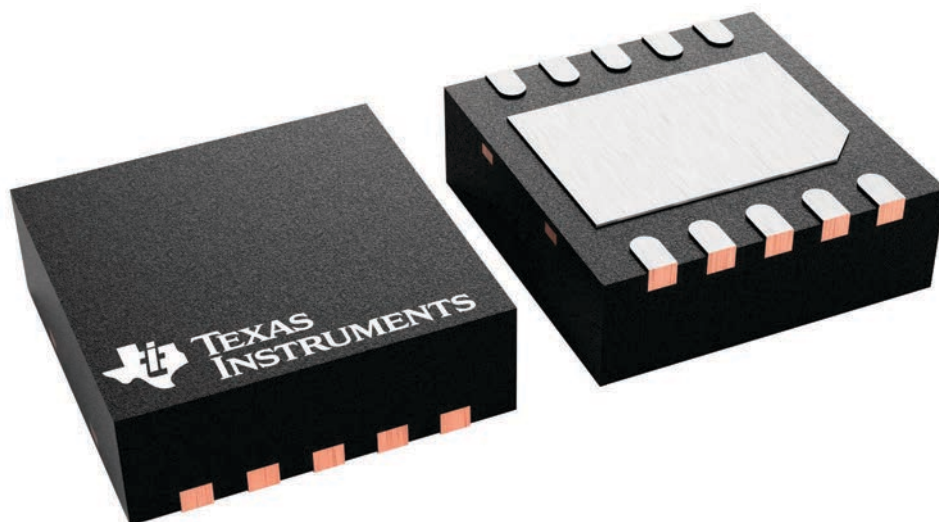
DRC 10

VSON - 1 mm max height

3 x 3, 0.5 mm pitch

PLASTIC SMALL OUTLINE - NO LEAD

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

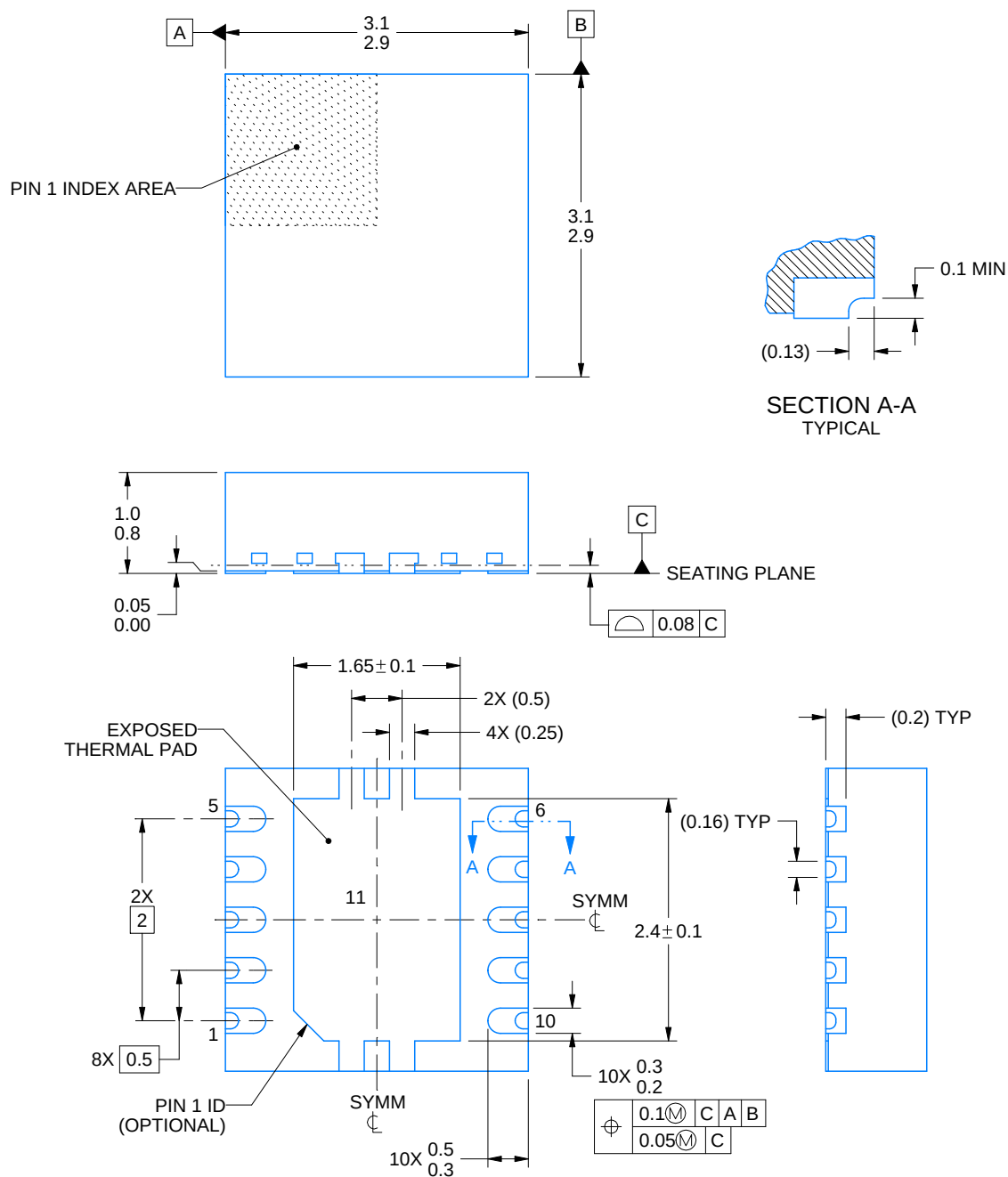


4226193/A



VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



4225163/A 07/2019

NOTES:

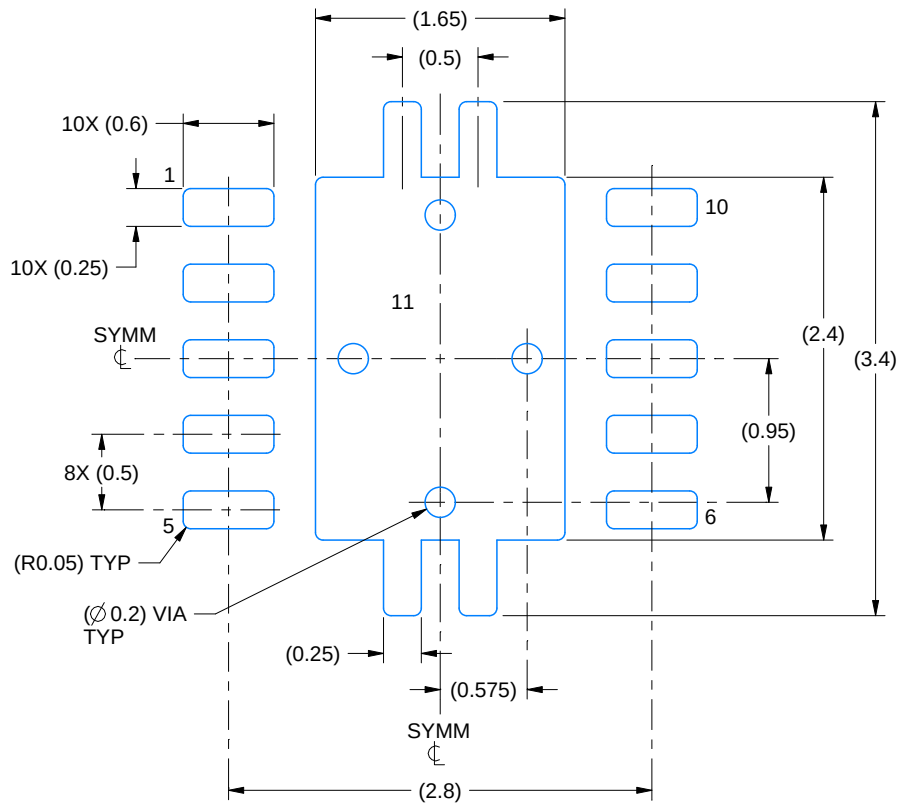
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

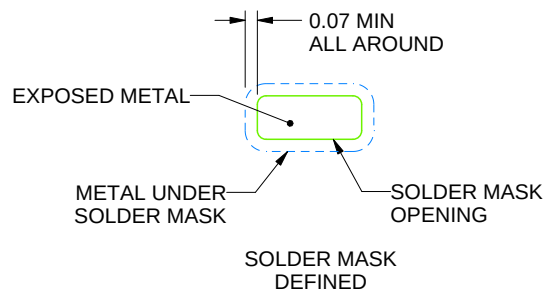
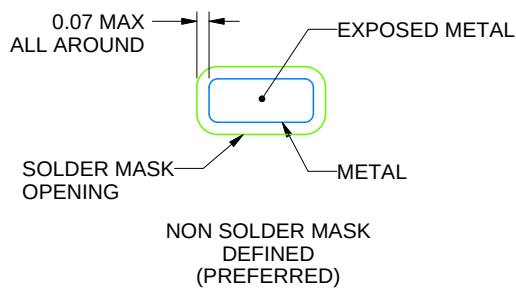
DRC0010U

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:20X



SOLDER MASK DETAILS

4225163/A 07/2019

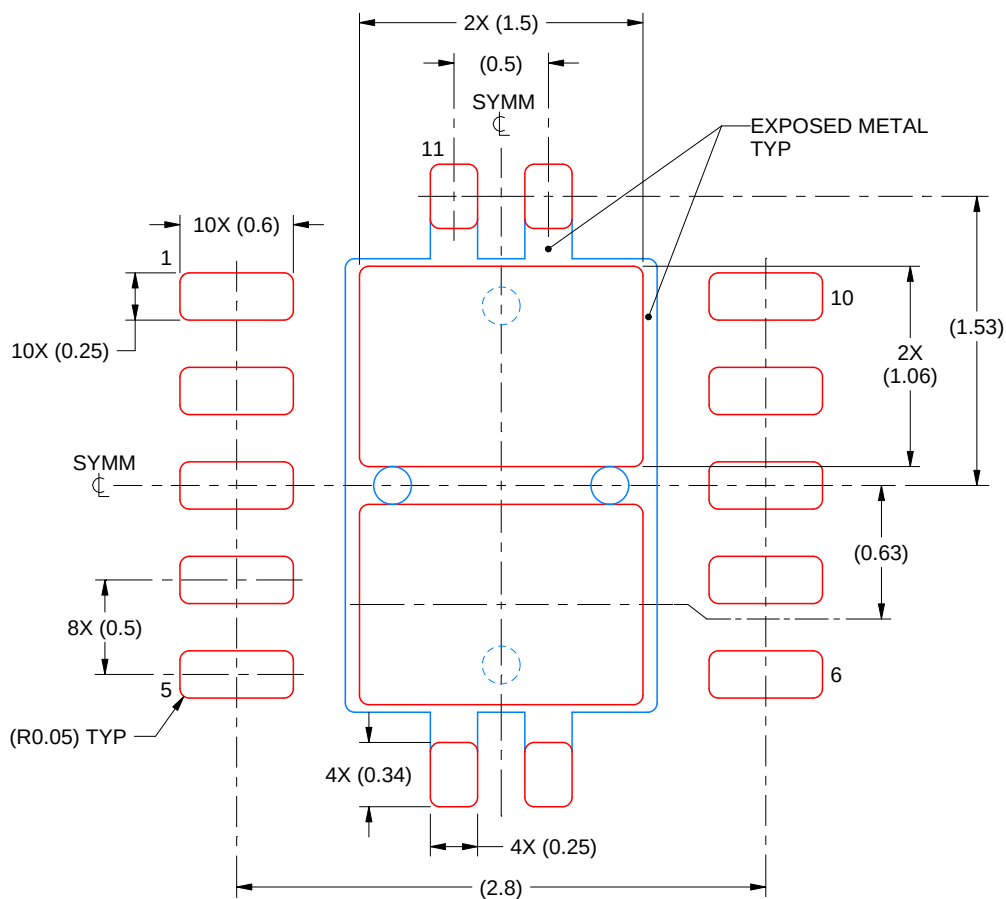
NOTES: (continued)

- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).
- Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

DRC0010U

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 11:
80% PRINTED SOLDER COVERAGE BY AREA
SCALE:25X

4225163/A 07/2019

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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